

Form PTO-1449 (MODIFIED)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 016790/0411	SERIAL NO. New Application		
INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)		APPLICANT		Fritz Juergen HOHN			
		FILING DATE FEB 15 2001		GROUP ART UNIT <i>2881</i> Not yet known			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
<i>PA</i>	A1	5,828,064	10/27/1998	Knowles	250	310	
FOREIGN PATENT DOCUMENTS							
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION
							YES
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER <i>Bruce Anderson</i>		DATE CONSIDERED <i>2/24/02</i>					
<p>* EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include any copy of this form with next communication to applicant.</p>							

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		APPLICANT Fritz Juergen HOHN	
		FILING DATE 02/15/2001	GROUP ART UNIT 288/ Unassigned

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION
							YES NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>PA</i>	A1	CHANG et al., "Electron Beam Technology – SEM To Microcolumn", <i>Microelectronic Engineering</i> , Elsevier
		Science B.V., Vol. 32:113-130, (1996)

EXAMINER	<i>Bruce Anderson</i>	DATE CONSIDERED
		<i>4-24-02</i>

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